

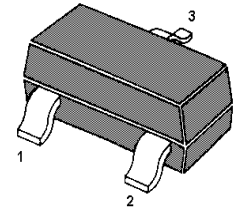
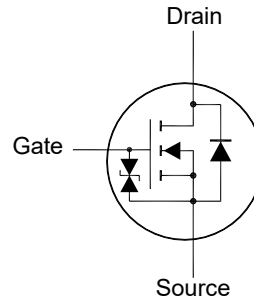
MMFTN3416K-HAF

N-Channel Enhancement Mode MOSFET

Features

- Halogen and Antimony Free(HAF),
RoHS compliant
- Typical ESD Protection HBM Class 1B

Classification	Voltage Range(V)
0A	< 125
0B	125 to < 250
1A	250 to < 500
1B	500 to < 1000
1C	1000 to < 2000
2	2000 to < 4000
3A	4000 to < 8000
3B	≥ 8000



1. Gate 2. Source 3. Drain
TO-236 Plastic Package

Applications

- Portable appliances
- Battery management
- High speed switch
- Low power DC to DC

Absolute Maximum Ratings($T_a = 25^\circ\text{C}$)

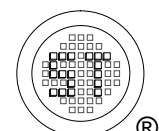
Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 8	V
Continuous Drain Current	I_D	6.5	A
Peak Drain Current, Pulesd ¹⁾	I_{DM}	30	A
Power Dissipation	P_D	1.4	W
Operating Junction Temperature Range	T_j	- 55 to + 150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	- 55 to + 150	$^\circ\text{C}$

Thermal Resistance Ratings

Parameter	Symbol	Max.	Unit
Thermal Resistance from Junction to Ambient ²⁾	$R_{\theta JA}$	89	$^\circ\text{C/W}$

¹⁾ Pulse Test: Pulse Width $\leq 100 \mu\text{s}$, Duty Cycle $\leq 2\%$, Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})} = 150^\circ\text{C}$.

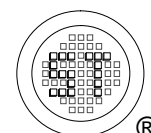
²⁾ Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate, $t \leq 10 \text{ s}$.



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Characteristics at $T_a = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at $I_D = 250\ \mu\text{A}$	$V_{(BR)DSS}$	20	-	-	V
Gate Voltage Drain Current at $V_{DS} = 16\ \text{V}$	I_{DSS}	-	-	1	μA
Gate-Source Leakage at $V_{GS} = \pm 4.5\ \text{V}$ at $V_{GS} = \pm 8\ \text{V}$	I_{GSS}	- -	- -	± 1 ± 10	μA
Gate-Source Threshold Voltage at $V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$	$V_{GS(th)}$	0.4	-	1	V
Drain-Source On-State Resistance at $V_{GS} = 4.5\ \text{V}$, $I_D = 6.5\ \text{A}$ at $V_{GS} = 2.5\ \text{V}$, $I_D = 5.5\ \text{A}$ at $V_{GS} = 1.8\ \text{V}$, $I_D = 5\ \text{A}$	$R_{DS(on)}$	- - -	- - -	22 26 34	m Ω
DYNAMIC PARAMETERS					
Gate Resistance at $V_{GS} = 0\ \text{V}$, $V_{DS} = 0\ \text{V}$, $f = 1\ \text{MHz}$	R_g	-	1.5	-	K Ω
Forward Transconductance at $V_{DS} = 5\ \text{V}$, $I_D = 6.5\ \text{A}$	g_{fs}	-	13	-	S
Input Capacitance at $V_{DS} = 10\ \text{V}$, $V_{GS} = 0\ \text{V}$, $f = 1\ \text{MHz}$	C_{iss}	-	564	-	pF
Output Capacitance at $V_{DS} = 10\ \text{V}$, $V_{GS} = 0\ \text{V}$, $f = 1\ \text{MHz}$	C_{oss}	-	120	-	pF
Reverse Transfer Capacitance at $V_{DS} = 10\ \text{V}$, $V_{GS} = 0\ \text{V}$, $f = 1\ \text{MHz}$	C_{rss}	-	25	-	pF
Total Gate Charge at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 4.5\ \text{V}$ at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 2.5\ \text{V}$	Q_g	- -	16 10	- -	nC
Gate Source Charge at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 4.5\ \text{V}$	Q_{gs}	-	1	-	nC
Gate Drain Charge at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 4.5\ \text{V}$	Q_{gd}	-	4	-	nC
Turn-On Delay Time at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 5\ \text{V}$, $R_{GEN} = 3\ \Omega$	$t_{d(on)}$	-	3.8	-	μs
Turn-On Rise Time at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 5\ \text{V}$, $R_{GEN} = 3\ \Omega$	t_r	-	1.9	-	μs
Turn-Off Delay Time at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 5\ \text{V}$, $R_{GEN} = 3\ \Omega$	$t_{d(off)}$	-	2.5	-	μs
Turn-Off Fall Time at $V_{DS} = 10\ \text{V}$, $I_D = 6.5\ \text{A}$, $V_{GS} = 5\ \text{V}$, $R_{GEN} = 3\ \Omega$	t_f	-	1	-	μs
Body-Diode PARAMETERS					
Body Diode Voltage at $I_S = 1\ \text{A}$	V_{SD}	-	-	1	V
Body Diode Reverse Recovery Time at $I_S = 5\ \text{A}$, $di/dt = 50\ \text{A} / \mu\text{s}$	t_{rr}	-	1.5	-	μs
Body Diode Reverse Recovery Charge at $I_S = 5\ \text{A}$, $di/dt = 50\ \text{A} / \mu\text{s}$	Q_{rr}	-	10	-	μC



MMFTN3416K-HAF

Electrical Characteristics Curves

Fig. 1 Input Characteristic

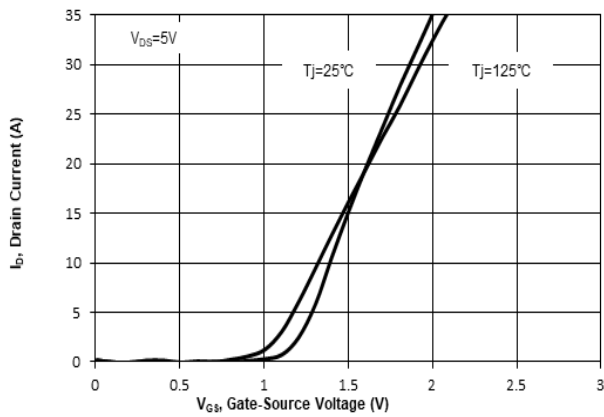


Fig. 2 Output Characteristics

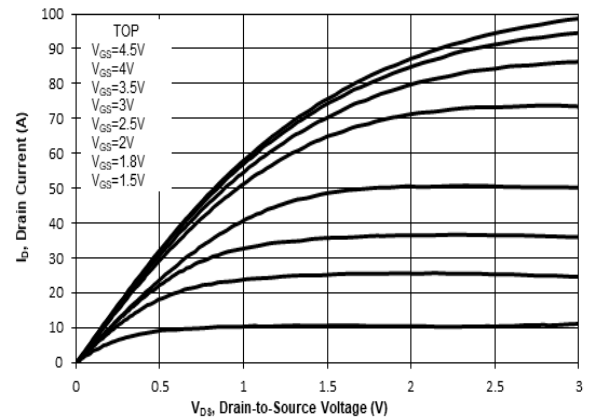


Fig. 3 On-Resistance vs. Drain Current

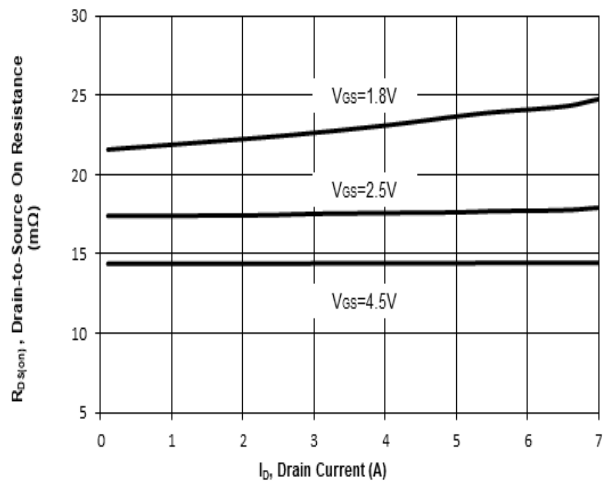


Fig. 4 On-Resistance vs. Gate-Source Voltage

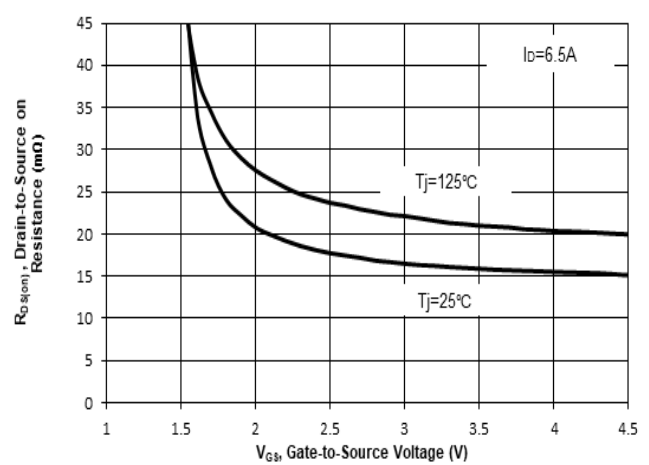


Fig. 5 On-Resistance vs. Junction Temperature

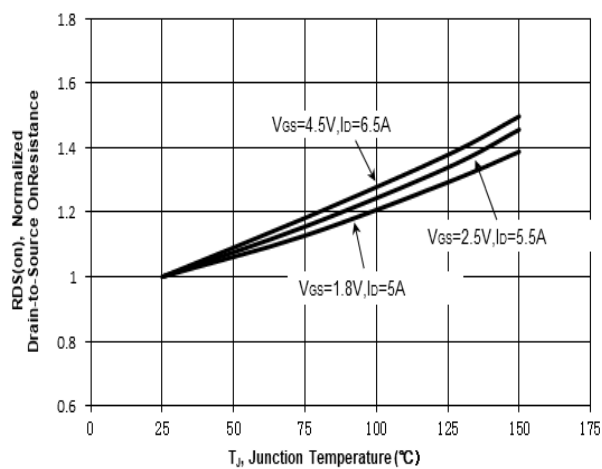
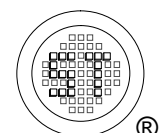
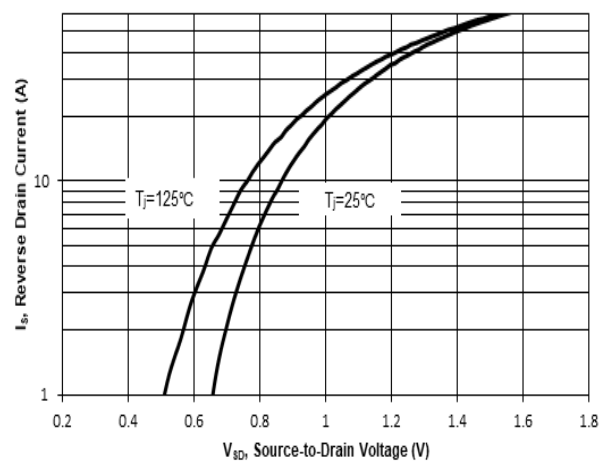


Fig. 6 Typical Forward Characteristics



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Electrical Characteristics Curves

Fig. 7 Capacitance Characteristic

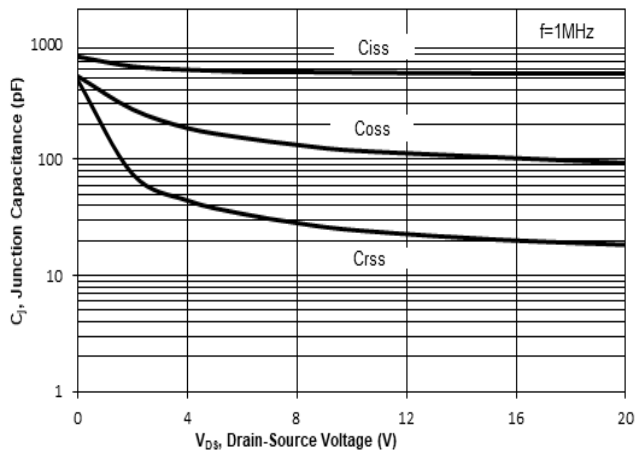


Fig. 8 IDSS vs. Junction Temperature

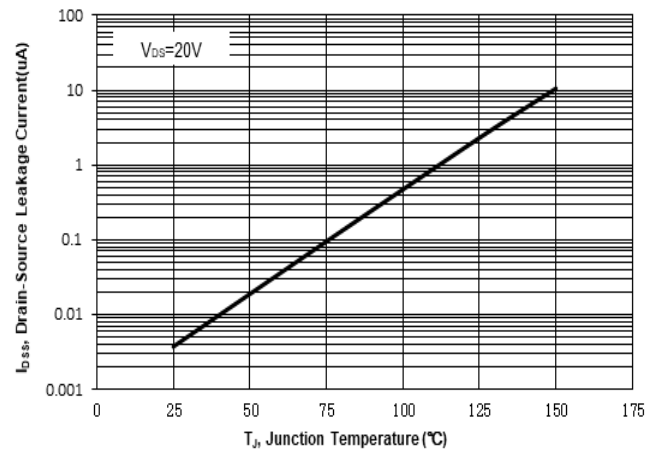


Fig. 9 BV_{DSS} Voltage vs. T_J

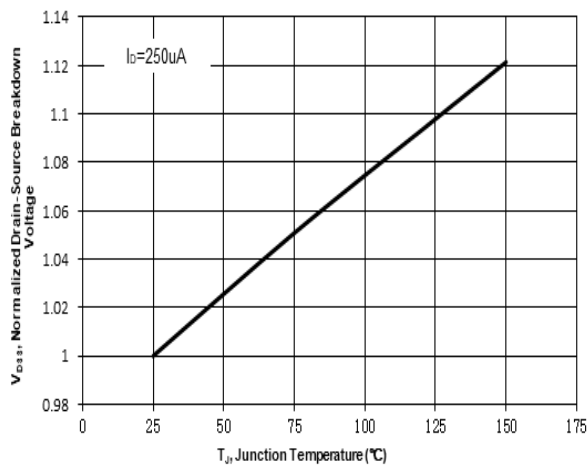


Fig. 10 Gate-Source Threshold Voltage vs. T_J

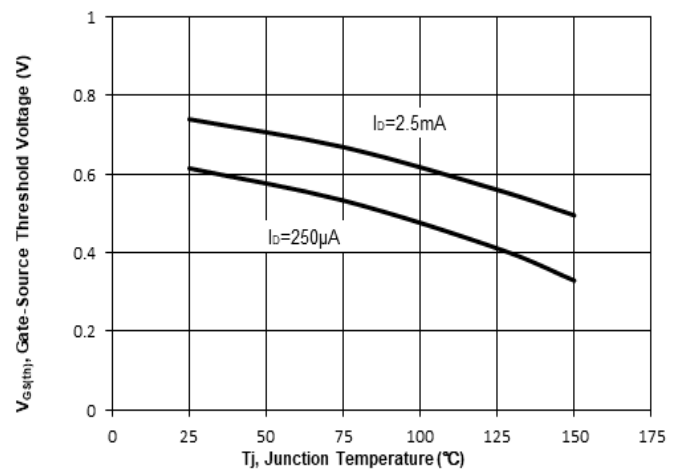
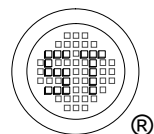
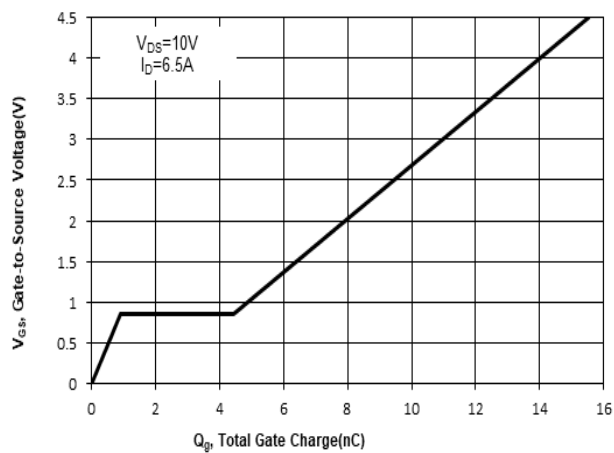


Fig. 11 Gate Charge



Test Circuits

Fig.1-1 Switching times test circuit

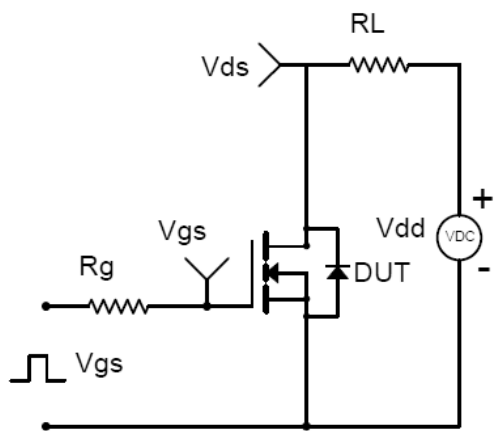


Fig.1-2 Switching Waveform

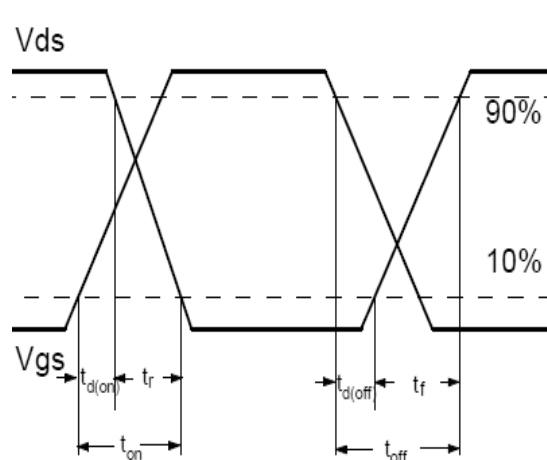


Fig.2-1 Gate charge test circuit

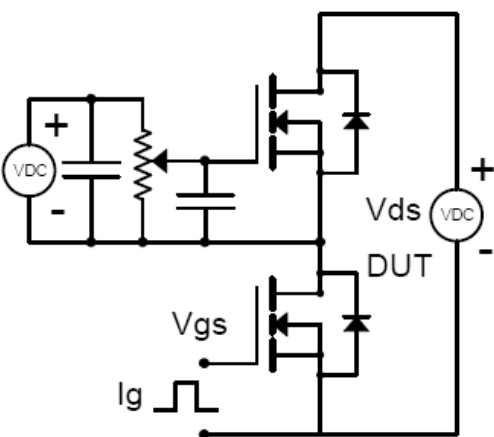
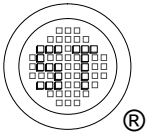
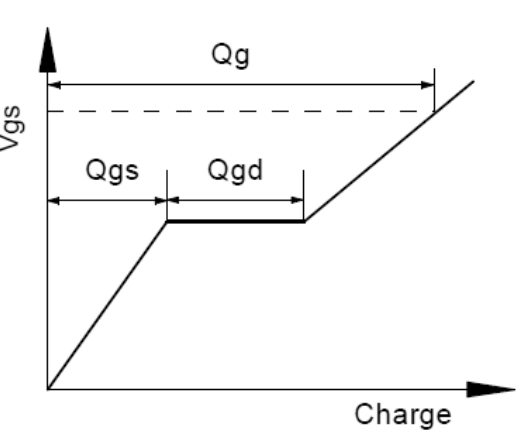


Fig.2-2 Gate charge waveform

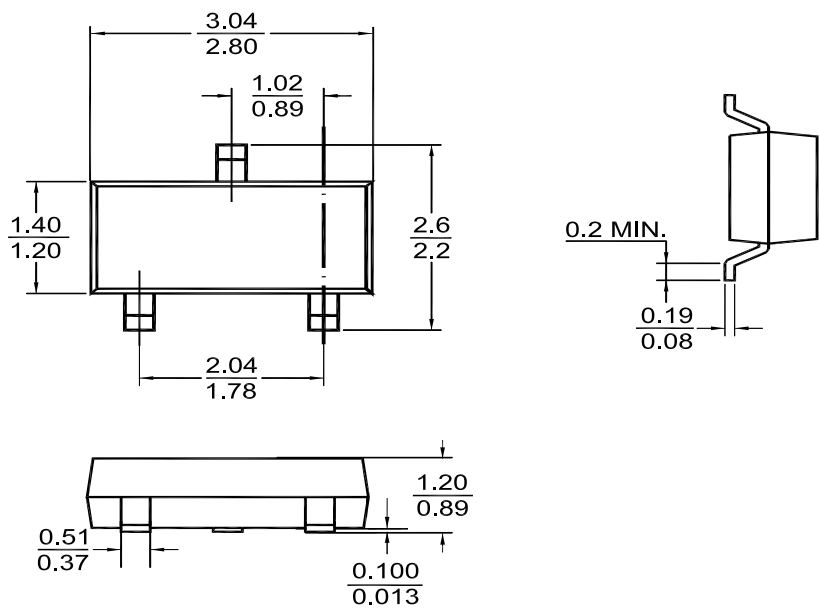


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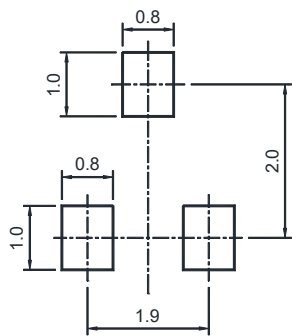
PACKAGE OUTLINE

Plastic surface mounted package (Dimensions in mm)

TO-236



Recommended Soldering Footprint



Packing information

Package	Tape Width (mm)	Pitch		Reel Size		Per Reel Packing Quantity
		mm	inch	mm	inch	
TO-236	8	4 ± 0.1	0.157 ± 0.004	178	7	3,000

Marking information

"VR" = Part No.
". " = HAF (Halogen and Antimony Free)
"YM" = Date Code Marking
"Y" = Year
"M" = Month
Font type: Arial

